

PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

A N	APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
	10051064	01/18/2002	438		2842	Isiedo
**APPLICANTS: Hamada Takashi; Murakami Satsohi; Yamazaki Shunpei; Nakamura Osamu; Kajiwara Masayuki; Koezuka Junichi; Takayama Toru; 2823						
**CONTINUING DATA VERIFIED: none <i>SKT</i>						
** FOREIGN APPLICATIONS VERIFIED: JAPAN 2001-011085 01/19/2001 <i>SKT</i> JAPAN 2001-022062 01/30/2001 <i>SKT</i>						
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>			RESCIND <input type="checkbox"/>			
Foreign priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no			35 USC 119 conditions met <input type="checkbox"/> yes <input type="checkbox"/> no		ATTORNEY DOCKET NO	
Verified and Acknowledged Examiners's initials <i>SKT</i>					SEL 299	
TITLE : Semiconductor device and method of manufacturing the same						
U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)						

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED		
		Assistant Examiner	Total Claims	
			Print Claim for Q.G.	
ISSUE FEE		Primary Examiner	DRAWING	
Amount Due	Date Paid		Sheets Drwg.	Figs. Drwg.
<input type="checkbox"/> TERMINAL DISCLAIMER		PREPARED FOR ISSUE	Application Examiner	
WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.				

FILED WITH:

☐ DISK (CRF)

☐ CD-ROM

(Attached in pocket on right inside flap)